

Search Notes

Application/Control No.

09/784,254

Examiner

Ellen C. Tran

Applicant(s)/Patent under
Reexamination

FURUYA ET AL.

Art Unit

2134

SEARCHED

Class	Subclass	Date	Examiner
380	210	5/24/2005	ECT
380	200	5/24/2005	ECT
380	212	5/24/2005	ECT
713	169	5/24/2005	ECT
380	28	5/24/2005	ECT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Todd Swann / 101 Help Panel	5/24/2005	ECT
USPTO, USPG, EPO, JPO, DERWENT, IBM TECH DES	5/24/2005	ECT